

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/560,168	<b>Applicant(s)/Patent under Reexamination</b> SHINMEN ET AL.
	<b>Examiner</b> TUYEN T. NGUYEN	<b>Art Unit</b> 2832

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
same as above		7/7/2007	TN